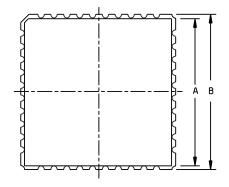
INCH-POUND
MIL-PRF-55310/29C
25 March 2011
SUPERSEDING
MIL-PRF-55310/29B
24 February 2005

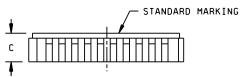
PERFORMANCE SPECIFICATION SHEET

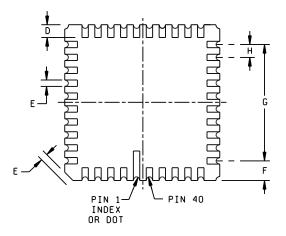
OSCILLATOR, CRYSTAL CONTROLLED, TYPE 1 (CRYSTAL OSCILLATOR (XO)), 0.2 MHz THROUGH 85 MHz, HERMETIC SEAL, SQUARE WAVE, HCMOS

This specification is approved for use by all Departments and Agencies of the Department of Defense.

The requirements for acquiring the product described herein shall consist of this specification and MIL-PRF-55310.







Pin number	Function		
4	B+		
10	B+		
31	GND		
32	Disable/enable		
37	GND		
39	Output		
1-3	NC		
5-9	NC		
11-30	NC		
33-36	NC		
38	NC		
40	NC		

FIGURE 1. Dimensions and configuration.

AMSC N/A FSC 5955

Ltr	Inches		mm		
	Min	Max	Min	Max	
Α	.454	.466	11.53	11.84	
В	.465 SQ	.495 SQ	11.81 SQ	12.57 SQ	
С		.085		2.16	
D	.033	.047	0.84	11.94	
Е	.015	.025	0.38	0.63	
F	.055	.070	1.40	1.78	
G	.355 SQ	.365 SQ	9.02 SQ	9.27 SQ	
Н	.035	.045	0.89	1.14	

NOTES:

- Dimensions are in inches.
 Metric equivalents are given for general information only.
 Unless otherwise specified, tolerances are ±.005 (0.13 mm) for three place decimals and ±.02 (0.5 mm) for two place decimals.

 4 All pads with NC functions are not connected externally.

FIGURE 1. <u>Dimensions and configuration</u> - Continued.

REQUIREMENTS:

Interface and physical dimensions: See figure 1.

Mounting: See figure 1.

Pads: See figure 1.

Seal: Hermetic in accordance with MIL-PRF-55310, maximum leakage rate 5 x 10⁻⁸ atm cc/s.

Weight: 3 grams, maximum.

Oscillator: Class 2 or any class 1 or class 3 oscillator meeting all class 2 requirements and verification tests specified herein and in MIL-PRF-55310.

Calibration: Manufacturer calibrated.

Screening: In accordance with MIL-PRF-55310, product level B or S, as applicable.

Temperature:

Operating: See table I.

Storage: -62°C to +125°C.

Load test circuit: See figure 2.

Supply voltage: +5.0 V dc ±10 percent.

Supply current: See table I.

Overvoltage survivability: In accordance with MIL-PRF-55310.

Start-up time: 15 ms maximum, measurement shall be taken at reference temperature and operating temperature range end points.

Nominal output frequency: Specified nominal frequency (see table I).

Output levels at designated load: See figure 3.

 $Logic \ 1: \ 0.9 \ V_{DD}, \ minimum.$

Logic 0: 0.1 V_{DD}, maximum.

Output waveform: Symmetrical square wave, HCMOS logic compatible (see figure 3).

Duty cycle: See table I and figure 3.

Rise and fall times: See table I and figure 3.

Enable/disable:

Output disabled (high impedance): Pad 32 input = 0.8 V dc maximum.

Output enabled: Pad 32 input = 2.0 V dc minimum.

Initial frequency accuracy at +23°C: See table I.

TABLE I. Dash numbers and operating characteristics.

					•	_			1
Dash	Output	Input	Pulse characteristics		Initial	Frequency	Frequency-temperature		ature
number	frequency	current	1		accuracy	aging	tolerance (ppm)		1)
	range	(max)	Rise and	Duty Cycle	at +23°C	ppm/year	-55/C	-55/C	-20/C
		1/	fall times	min-max	±1°C	(max) <u>3</u> /	to	to	to
		_	(max)	<u>4</u> /	<u>2</u> /	, , _	+125/C	+105/C	+70/C
					<u> </u>		Α	В	С
01	0.2 MHz	10 mA	10 ns	45% to 55%	±15 ppm	±5 ppm	±65 ppm	±55 ppm	±40 ppm
to									
02	5.0 MHz	10 mA	10 ns		±25 ppm	±10 ppm	±100 ppm	±75 ppm	±50 ppm
11	5.0 MHz	20 mA	10 ns	45% to 55%	±15 ppm	±5 ppm	±65 ppm	±55 ppm	±40 ppm
to									
12	25.0 MHz	20 mA	10 ns		±25 ppm	±10 ppm	±100 ppm	±75 ppm	±50 ppm
21	25.0 MHz	30 mA	5 ns	45% to 55%	±15 ppm	±5 ppm	±65 ppm	±55 ppm	±40 ppm
to									
22	40.0 MHz	30 mA	5 ns		±25 ppm	±10 ppm	±100 ppm	±75 ppm	±50 ppm
31	40.0 MHz	40 mA	5 ns	40% to 60%	±15 ppm	±5 ppm	±65 ppm	±55 ppm	±40 ppm
to									
32	60.0 MHz	40 mA	5 ns		±25 ppm	±10 ppm	±100 ppm	±75 ppm	±50 ppm
41	60.0 MHz	60 mA	5 ns	40% to 60%	±15 ppm	±5 ppm	±65 ppm	±55 ppm	±40 ppm
to									• • •
42	85.0 MHz	60 mA	5 ns		±25 ppm	±10 ppm	±100 ppm	±75 ppm	±50 ppm

- 1/ Maximum input current for no load condition.
 2/ Up to 30 days following shipment.
 3/ After 30 days following shipment.

- 4/ See figure 3.

TABLE II. Frequency aging limits.

	±5 ppm per year <u>1</u> /	±10 ppm per year <u>1</u> /
Maximum change over 30 days	±0.7 ppm	±1.5 ppm
Projected maximum change for 1 year after 30 days	±5.0 ppm	±10.0 ppm

^{1/} See table I.

Initial frequency - temperature accuracy (1/2 temperature cycle): See table I. Measurements shall be taken at ten equally spaced increments over the specified operating temperature range.

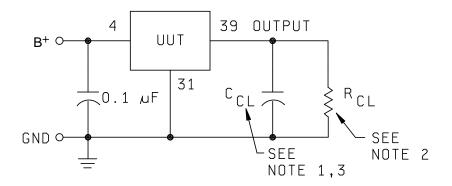
Frequency - voltage tolerance for ±10 percent change in supply voltage:

For output frequency \leq 40.0 MHz: \pm 2 ppm, maximum.

For output frequency \geq 40.0 MHz: \pm 4 ppm, maximum.

Frequency - environmental tolerance: ±3 ppm.

Frequency aging: Frequency aging shall be in accordance with MIL-PRF-55310 and shall meet the limits of table II.



NOTES:

- 1. For HCMOS: C_{CL} = 15 pF ±5 percent. 2. For HCMOS: R_{CL} = 10 k Ω ±5 percent. 3. C_{CL} includes scope capacitance.

FIGURE 2. Load test circuit.

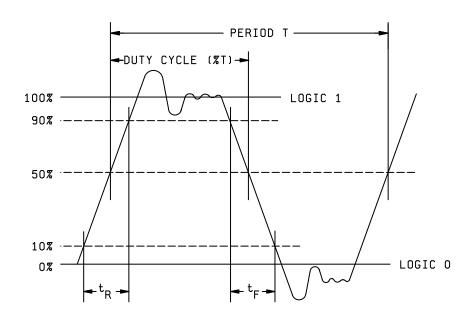


FIGURE 3. Waveform.

Vibration, sinusoidal: In accordance with MIL-PRF-55310 and method 204 of MIL-STD-202.

Nonoperating: Test condition D.

Operating: Not required.

Shock, non-operating: Method 213 of MIL-STD-202, condition I.

Thermal shock: Method 107 of MIL-STD-202, condition B.

Ambient pressure:

Nonoperating: In accordance with MIL-PRF-55310.

Operating: Method 105 of MIL-STD-202, test condition C.

Storage temperature: In accordance with MIL-PRF-55310.

Reflow soldering: Reflow soldering of the unit at +230°C ± 10°C for 15 seconds shall not degrade the performance.

Moisture resistance: Method 106 of MIL-STD-202.

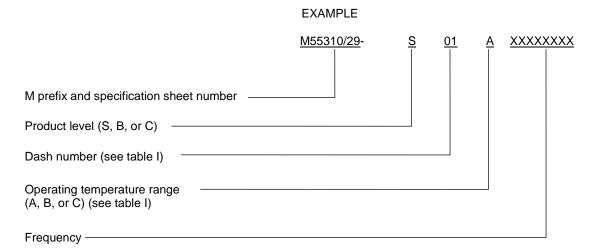
Pad strength: In accordance with method 2004 of MIL-STD-883, condition D.

Solderability: Method 208 of MIL-STD-202.

Resistance to solvents: Method 215 of MIL-STD-202.

Screening: In accordance with MIL-PRF-55310, class B or S, as applicable.

Part or Identifying Number (PIN): Consists of "M" prefix followed by specification sheet number, a dash and coded alphas, and numeric number. See example:



Reference documents. In addition to MIL-PRF-55310, this document references the following:

MIL-STD-202 MIL-STD-883

NASA - NA

The margins of this specification sheet are marked with vertical lines to indicate where changes from the previous issue were made. This was done as a convenience only and the Government assumes no liability whatsoever for any inaccuracies in these notations. Bidders and contractors are cautioned to evaluate the requirements of this document based on the entire content irrespective of the marginal notations and relationship to the last previous

Custodians:

Preparing activity: Army - CR Army - CR

Navy - EC Air Force - 99 Agent: DLA - CC DLA - CC

Review activities: Army - AR, MI, SM (5955-2011-016)

Navy - AS, CG, MC Air Force - 19, 84

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